MEMORY cmos

4 × 2 M × 8 BIT SYNCHRONOUS DYNAMIC RAM

MB81F64842D-75/-102/-102L

CMOS 4-Bank \times 2,097,152-Word \times 8 Bit Synchronous Dynamic Random Access Memory

■ DESCRIPTION

The Fujitsu MB81F64842D is a CMOS Synchronous Dynamic Random Access Memory (SDRAM) containing 67,108,864 memory cells accessible in a 8-bit format. The MB81F64842D features a fully synchronous operation referenced to a positive edge clock whereby all operations are synchronized at a clock input which enables high performance and simple user interface coexistence. The MB81F64842D SDRAM is designed to reduce the complexity of using a standard dynamic RAM (DRAM) which requires many control signal timing constraints, and may improve data bandwidth of memory as much as 5 times more than a conventional DRAM.

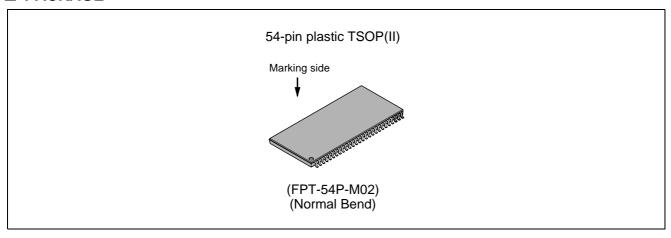
The MB81F64842D is ideally suited for workstations, personal computers, laser printers, high resolution graphic adapters/accelerators and other applications where an extremely large memory and bandwidth are required and where a simple interface is needed.

■ PRODUCT LINE & FEATURES

			MB81F64842D	
Parameter		-75	-102/-102L	Reference Value @66MHz(CL=2)
CL - tRCD - tRP		3 - 3 - 3 clk min.	2 - 2 - 2 clk min.	2 - 2 - 2 clk min.
Clock Frequency		133 MHz max.	100 MHz max.	66 MHz max.
Burst Mode Cycle Time	CL = 2	10 ns min.	10 ns min.	15ns min.
burst wode Cycle Time	CL = 3	7.5 ns min.	10 ns min.	10 ns min.
Access Time from Clock	CL = 2	6 ns max.	6 ns max.	8 ns max.
Access Time Hom Clock	CL = 3	5.4 ns max.	6 ns max.	6 ns max.
Operating Current		85 mA max.	80 mA max.	65 mA max.
Power Down Mode Current	(ICC2P)	1 mA max.	1 mA max.	1 mA max.
Self Refresh Current (Icce)		1 mA max.	1 mA max./ 500 μA max.	1 mA max.

- Single +3.3 V Supply ±0.3 V tolerance
- LVTTL compatible I/O interface
- 4 K refresh cycles every 64 ms
- Four bank operation
- Burst read/write operation and burst read/single write operation capability
- Programmable burst type, burst length, and CAS latency
- Auto-and Self-refresh (every 15.6 μs)
- CKE power down mode
- Output Enable and Input Data Mask

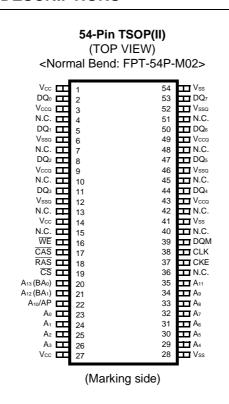
■ PACKAGE



Package and Ordering Information

 54-pin plastic (400 mil) TSOP-II, order as MB81F64842D-xxxFN (Standard version) or MB81F64842D-xxxLFN (Low power version)

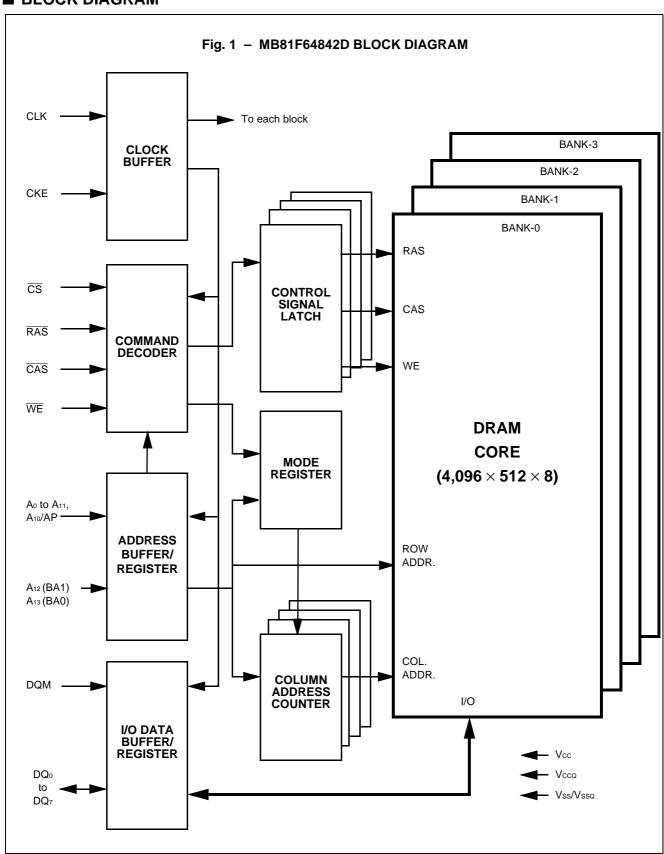
■ PIN ASSIGNMENTS AND DESCRIPTIONS



Pin Number	Symbol	Function
1, 3, 9, 14, 27, 43, 49	Vcc, Vccq	Supply Voltage
2, 5, 8, 11, 44, 47, 50, 53	DQ ₀ to DQ ₇	Data I/O
6, 12, 28, 41, 46, 52, 54	Vss, Vssq *	Ground
4, 7, 10, 13, 15, 36, 40, 42, 45, 48, 51	N.C.	No Connection
16	WE	Write Enable
17	CAS	Column Address Strobe
18	RAS	Row Address Strobe
19	CS	Chip Select
20, 21	A ₁₃ (BA ₀), A ₁₂ (BA ₁)	Bank Select (Bank Address)
22	AP	Auto Precharge Enable
22, 23, 24, 25, 26, 29, 30, 31, 32, 33, 34, 35	A ₀ to A ₁₁	Address Input • Row: A ₀ to A ₁₁ • Column: A ₀ to A ₈
37	CKE	Clock Enable
38	CLK	Clock Input
39	DQM	DQ MASK

^{*:} These pins are connected internally in the chip.

■ BLOCK DIAGRAM



■ FUNCTIONAL TRUTH TABLE Note *1 COMMAND TRUTH TABLE Note *2, *3, and *4

Function	Notes	Symbol	CI	ΚE	CS	RAS	CAS	WE	A ₁₃ ,	A 11	A 10	A 9	A ₈
i diletion	NOIGS	Symbol	n-1	n	CS	INAG	CAS	VVL	(BA)	A 11	(AP)	A9	A ₀
Device Deselect	*5	DESL	Н	Х	Н	Х	Х	Χ	Х	Χ	Х	Χ	Х
No Operation	*5	NOP	Н	Х	L	Н	Н	Н	Х	Χ	Х	Χ	Х
Burst Stop		BST	Н	Х	L	Н	Н	L	Х	Χ	Х	Χ	Х
Read	*6	READ	Н	Х	L	Н	L	Н	V	Х	L	Χ	V
Read with Auto-precharge	*6	READA	Н	Х	L	Н	L	Н	V	Х	Н	Χ	V
Write	*6	WRIT	Н	Х	L	Н	L	L	V	Х	L	Х	V
Write with Auto-precharge	*6	WRITA	Н	Х	L	Н	L	L	V	Χ	Н	Χ	V
Bank Active	*7	ACTV	Н	Х	L	L	Н	Н	V	٧	V	V	V
Precharge Single Bank		PRE	Н	Х	L	L	Н	L	V	Х	L	Χ	Х
Precharge All Banks		PALL	Н	Χ	L	L	Н	L	Х	Х	Н	Χ	Х
Mode Register Set	*8, 9	MRS	Н	Χ	L	L	L	L	L	L	L	V	V

Notes: *1. V = Valid, L = Logic Low, H = Logic High, X = either L or H.

- *2. All commands assumes no CSUS command on previous rising edge of clock.
- *3. All commands are assumed to be valid state transitions.
- *4. All inputs are latched on the rising edge of clock.
- *5. NOP and DESL commands have the same effect on the part. Unless spcifically noted, NOP will represent both NOP and DESL command in later discriptions.
- *6. READ, READA, WRIT and WRITA commands should only be issued after the corresponding bank has been activated (ACTV command). Refer to STATE DIAGRAM.
- *7. ACTV command should only be issued after corresponding bank has been precharged (PRE or PALL command).
- *8. Required after power up. Refer to POWER-UP INITIALIZATION in page 19.
- *9. MRS command should only be issued after all banks have been precharged (PRE or PALL command). Refer to STATE DIAGRAM.

DQM TRUTH TABLE

Function	Symbol	CI	KE	DQM
Function	Symbol	n-1	n	DQW
Data Write/Output Enable	ENBL	Н	Х	L
Data Mask/Output Disable	MASK	Н	Х	Н

CKE TRUTH TABLE

Current	Function N	otos	Cumbal	Cł	(E	cs	RAS	CAS	WE	A ₁₃ ,	A 11	A 10	A ₉
State	runction N	otes	Symbol	n-1	n	CS	KAS	CAS	VVE	A ₁₂ (BA)	A 11	(AP)	A ₀
Bank Active	Clock Suspend Mode Entry	*1	CSUS	Н	L	Χ	Х	Х	Χ	Х	Χ	Х	Χ
Any (Except Idle)	Clock Suspend Continue	*1		L	L	Х	Х	Х	X	Χ	X	Х	Х
Clock Suspend	Clock Suspend Mode Exit			L	Н	Х	Х	Х	Х	Х	Х	Х	Х
Idle	Auto-refresh Command	*2	REF	Н	Н	L	L	L	Н	Х	Χ	Х	Χ
Idle	Self-refresh Entry	*2, 3	SELF	Н	L	L	L	L	Η	Х	Χ	Х	Χ
Self Refresh	Self-refresh Exit		SELFX	L	Н	L	Н	Н	Н	Х	Χ	Х	Χ
Sell Reliesh	Sell-refresh Exit		SELFX	L	Н	Н	Х	Х	Χ	Х	Χ	Х	Χ
Idlo	Dower Down Entry	*3	PD	Н	L	L	Н	Н	Н	Х	Χ	Х	Χ
Idle	Power Down Entry	3	PD	Н	L	Н	Х	Х	Х	Х	Χ	Х	Χ
Dower Down	Power Down Exit			L	Н	L	Н	Н	Н	Х	Χ	Х	Χ
Power Down	FOWEI DOWN EXIL			L	Н	Н	Х	Χ	X	Χ	Χ	Х	Χ

- **Notes:** *1. The CSUS command requires that at least one bank is active. Refer to STATE DIAGRAM. NOP or DESL commands should be issued after CSUS and PRE(or PALL) commands asserted at the same time.
 - *2. REF and SELF commands should only be issued after all banks have been precharged (PRE or PALL command). Refer to STATE DIAGRAM.
 - *3. SELF and PD commands should only be issued after the last read data have been appeared on DQ.

OPERATION COMMAND TABLE (Applicable to single bank) Note *1

Current State	CS	RAS	CAS	WE	Addr	Command	Function Notes
Idle	Н	Х	Х	Х	Х	DESL	NOP
	L	Н	Н	Н	Х	NOP	NOP
	L	Н	Н	L	Х	BST	NOP
	L	Н	L	Н	BA, CA, AP	READ/READA	Illegal *2
	L	Н	L	L	BA, CA, AP	WRIT/WRITA	Illegal *2
	L	L	Н	Н	BA, RA	ACTV	Bank Active after tRCD
	L	L	Н	L	BA, AP	PRE/PALL	NOP
	L	L	L	Н	Х	REF/SELF	Auto-refresh or Self-refresh *3, 6
	L	L	L	L	MODE	MRS	Mode Register Set *3, 7 (Idle after trsc)
Bank Active	Н	Х	Х	Х	Х	DESL	NOP
	L	Н	Н	Н	Х	NOP	NOP
	L	Н	Н	L	Х	BST	NOP
	L	Н	L	Н	BA, CA, AP	READ/READA	Begin Read; Determine AP
	L	Н	L	L	BA, CA, AP	WRIT/WRITA	Begin Write; Determine AP
	L	L	Н	Н	BA, RA	ACTV	Illegal *2
	L	L	Н	L	BA, AP	PRE/PALL	Precharge; Determine Precharge Type
	L	L	L	Н	Х	REF/SELF	Illegal
	L	L	L	L	MODE	MRS	Illegal

Current State	cs	RAS	CAS	WE	Addr	Command	Function Notes
Read	Н	Х	Х	Х	Х	DESL	NOP (Continue Burst to End → Bank Active)
	L	Н	Н	Н	Х	NOP	NOP (Continue Burst to End → Bank Active)
	L	Н	Н	L	Х	BST	Burst Stop → Bank Active
	L	Н	L	Н	BA, CA, AP	READ/READA	Terminate Burst, New Read; Determine AP
	L	Н	L	L	BA, CA, AP	WRIT/WRITA	Terminate Burst, Start Write; Determine AP *4
	L	L	Н	Н	BA, RA	ACTV	Illegal *2
	L	L	Н	L	BA, AP	PRE/PALL	Terminate Burst, Precharge → Idle; Determine Precharge Type
	L	L	L	Н	Х	REF/SELF	Illegal
	L	L	L	L	MODE	MRS	Illegal
Write	Н	Х	Х	Х	Х	DESL	NOP (Continue Burst to End → Bank Active)
	L	Н	Н	Н	Х	NOP	NOP (Continue Burst to End → Bank Active)
	L	Н	Н	L	Х	BST	Burst Stop → Bank Active
	L	Н	L	Н	BA, CA, AP	READ/READA	Terminate Burst, Start Read; *4 Determine AP
	L	Н	L	L	BA, CA, AP	WRIT/WRITA	Terminate Burst, New Write; Determine AP
	L	L	Н	Н	BA, RA	ACTV	Illegal *2
	L	L	Н	L	BA, AP	PRE/PALL	Terminate Burst, Precharge; Determine Precharge Type
	L	L	L	Н	Х	REF/SELF	Illegal
	L	L	L	L	MODE	MRS	Illegal

Current State	cs	RAS	CAS	WE	Addr	Command	Function Notes
Read with Auto- precharge	Н	Х	х	Х	Х	DESL	NOP (Continue Burst to End \rightarrow Precharge \rightarrow Idle)
precharge	L	Н	Н	Н	Х	NOP	NOP (Continue Burst to End \rightarrow Precharge \rightarrow Idle)
	L	Н	Н	L	Х	BST	Illegal
	L	Н	L	Н	BA, CA, AP	READ/READA	Illegal *2
	L	Н	L	L	BA, CA, AP	WRIT/WRITA	Illegal *2
	L	L	Н	Н	BA, RA	ACTV	Illegal *2
	L	L	Н	L	BA, AP	PRE/PALL	Illegal *2
	L	L	L	Н	Х	REF/SELF	Illegal
	L	L	L	L	MODE	MRS	Illegal
Write with Auto- precharge	Н	х	Х	Х	Х	DESL	NOP (Continue Burst to End \rightarrow Precharge \rightarrow Idle)
precharge	L	Н	Н	Н	Х	NOP	NOP (Continue Burst to End \rightarrow Precharge \rightarrow Idle)
	L	Н	Н	L	Х	BST	Illegal
	L	Н	L	Н	BA, CA, AP	READ/READA	Illegal *2
	L	Н	L	L	BA, CA, AP	WRIT/WRITA	Illegal *2
	L	L	Н	Н	BA, RA	ACTV	Illegal *2
	L	L	Н	L	BA, AP	PRE/PALL	Illegal *2
	L	L	L	Н	Х	REF/SELF	Illegal
	L	L	L	L	MODE	MRS	Illegal

Current State	cs	RAS	CAS	WE	Addr	Command	Function	Notes
Pre- charging	Н	Х	Х	Х	Х	DESL	NOP (Idle after t _{RP})	
Charging	L	Н	Н	Н	Х	NOP	NOP (Idle after t _{RP})	
	L	Н	Н	L	Х	BST	NOP (Idle after t _{RP})	
	L	Н	L	Н	BA, CA, AP	READ/READA	Illegal	*2
	L	Н	L	L	BA, CA, AP	WRIT/WRITA	Illegal	*2
	L	L	Н	Н	BA, RA	ACTV	Illegal	*2
	L	L	Н	L	BA, AP	PRE/PALL	NOP (PALL may affect other bank)	*5
	L	L	L	Н	Х	REF/SELF	Illegal	
	L	L	L	L	MODE	MRS	Illegal	
Bank Activating	Н	Х	Х	Х	Х	DESL	NOP (Bank Active after tRCD)	
Activating	L	Н	Н	Н	Х	NOP	NOP (Bank Active after tRCD)	
	L	Н	Н	L	Х	BST	NOP (Bank Active after tRCD)	
	L	Н	L	Н	BA, CA, AP	READ/READA	Illegal	*2
	L	Н	L	L	BA, CA, AP	WRIT/WRITA	Illegal	*2
	L	L	Н	Н	BA, RA	ACTV	Illegal	*2
	L	L	Н	L	BA, AP	PRE/PALL	Illegal	*2
	L	L	L	Н	Х	REF/SELF	Illegal	
	L	L	L	L	MODE	MRS	Illegal	

(Continued)

Current State	CS	RAS	CAS	WE	Addr	Command	Function Notes
Refreshing	Н	Х	Х	Х	Х	DESL	NOP (Idle after t _{RC})
	L	Н	Н	Х	Х	NOP/BST	NOP (Idle after t _{RC})
	L	Н	L	Х	Х	READ/READA/ WRIT/WRITA	Illegal
	L	L	Н	Х	Х	ACTV/ PRE/PALL	Illegal
	L	L	L	Х	Х	REF/SELF/ MRS	Illegal
Mode Register	Н	Х	Х	Х	Х	DESL	NOP (Idle after trsc)
Setting	L	Н	Н	Н	Х	NOP	NOP (Idle after trsc)
	L	Н	Н	L	Х	BST	Illegal
	L	Н	L	Х	Х	READ/READA/ WRIT/WRITA	Illegal
	L	L	Х	Х	Х	ACTV/PRE/ PALL/REF/ SELF/MRS	Illegal

ABBREVIATIONS:

RA = Row Address
CA = Column Address
AP = Auto Precharge

Notes: *1. All entries in ORERATION COMMAND TABLE assume the CKE was High during the proceeding clock cycle and the current clock cycle.

Illegal means don't used command. If used, power up sequence be asserted after power shut down.

- *2. Illegal to bank in specified state; entry may be legal in the bank specified by BA, depending on the state of that bank.
- *3. Illegal if any bank is not idle.
- *4. Must satisfy bus contention, bus turn around, and/or write recovery requirements. Refer to TIMING DIAGRAM -11 & -12.
- *5. NOP to bank precharging or in idle state. May precharge bank specified by BA (and AP).
- *6. SELF command should only be issued after the last read data have been appeared on DQ.
- *7. MRS command should only be issued on condition that all DQ are in Hi-Z.

COMMAND TRUTH TABLE FOR CKE Note*1

Current State	CKE n-1	CKE n	cs	RAS	CAS	WE	Addr	Function Notes
Self- refresh	Н	Х	Х	Х	Х	Х	Х	Invalid
Terresir	L	Н	Н	Х	Х	Х	Х	Exit Self-refresh (Self-refresh Recovery → Idle after t _{RC})
	L	Н	L	Н	Н	Н	Х	Exit Self-refresh (Self-refresh Recovery \rightarrow Idle after t _{RC})
	L	Н	L	Н	Н	L	Х	Illegal
	L	Н	L	Н	L	Х	Х	Illegal
	L	Н	L	L	Х	Х	Х	Illegal
	L	L	Χ	Х	Х	Х	Х	NOP (Maintain Self-refresh)
Self- refresh	L	Х	Х	Х	Х	Х	Х	Invalid
Recovery	Н	Н	Н	Х	Х	Х	Х	Idle after tRC
	Н	Н	L	Н	Н	Н	Х	Idle after tRC
	Н	Н	L	Н	Н	L	Х	Illegal
	Н	Н	L	Н	L	Х	Х	Illegal
	Н	Н	L	L	Х	Х	Х	Illegal
	Н	L	Х	Х	Х	Х	Х	Illegal *2

Current State	CKE n-1	CKE n	CS	RAS	CAS	WE	Addr	Function Notes
Power Down	Н	Х	Χ	Х	Х	Х	Х	Invalid
Down	L	Н	Н	Х	Х	Χ	Х	Evit Davier Davin Made . Idla
	L	Н	L	Н	Н	Н	Х	- Exit Power Down Mode → Idle
	L	L	Χ	Х	Х	Х	Х	NOP (Maintain Power Down Mode)
	L	Н	L	L	Х	Х	Х	Illegal
	L	Н	L	Н	L	Х	Х	Illegal
	L	Н	L	Н	Н	L	Х	Illegal
All Banks	Н	Н	Н	Х	Х	Х	MODE	Refer to the Operation Command Table.
Idle	Н	Н	L	Н	Х	Х	MODE	Refer to the Operation Command Table.
	Н	Н	L	L	Н	Х	MODE	Refer to the Operation Command Table.
	Н	Н	L	L	L	Н	Х	Auto-refresh
	Н	Н	L	L	L	L	MODE	Refer to the Operation Command Table.
	Н	L	Н	Х	Х	Х	Х	Power Down
	Н	L	L	Н	Н	Н	Х	Power Down
	Н	L	L	Н	Н	L	Х	Illegal
	Н	L	L	Н	L	Х	Х	Illegal
	Н	L	L	L	Н	Х	Х	Illegal
	Н	L	L	L	L	Н	X	Self-refresh *3
	Н	L	L	L	L	L	Х	Illegal
	L	Х	Χ	Х	Х	Х	Х	Invalid

(Continued)

Current State	CKE n-1	CKE n	<u>cs</u>	RAS	CAS	WE	Addr	Function Notes
Bank Active Bank Activating Read/Write	Н	Н	Х	Х	Х	Х	Х	Refer to the Operation Command Table.
Read with Auto- precharge/	Н	L	Х	х	X	Х	Х	Begin Clock Suspend next cycle
Write with Auto- precharge	L	x	X	X	X	X	X	Invalid
Clock	Н	Х	Х	Х	Х	Х	Х	Invalid
Suspend	L	Н	Х	Х	Х	Х	Х	Exit Clock Suspend next cycle
	L	L	Х	Х	Х	Х	Х	Maintain Clock Suspend
Any State Other Than	L	Х	Х	Х	Х	Х	Х	Invalid
Listed	Н	Н	Х	Х	Х	Х	Х	Refer to the Operation Command Table.
, 13000	Н	L	Х	Х	Х	Х	Х	Illegal

Notes: *1. All entries in COMMAND TRUTH TABLE FOR CKE are specified at CKE(n) state and CKE input from CKE(n-1) to CKE(n) state must satisfy corresponding set up and hold time for CKE.

^{*2.} CKE should be held High for tRC period.

^{*3.} SELF command should only be issued after the last data have been appeared on DQ.

■ FUNCTIONAL DESCRIPTION

SDRAM BASIC FUNCTION

Three major differences between this SDRAM and conventional DRAMs are: synchronized operation, burst mode, and mode register.

The **synchronized operation** is the fundamental difference. An SDRAM uses a clock input for the synchronization, where the DRAM is basically asynchronous memory although it has been using two clocks, \overline{RAS} and \overline{CAS} . Each operation of DRAM is determined by their timing phase differences while each operation of SDRAM is determined by commands and all operations are referenced to a positive clock edge. Fig. 2 shows the basic timing diagram differences between SDRAMs and DRAMs.

The **burst mode** is a very high speed access mode utilizing an internal column address generator. Once a column addresses for the first access is set, following addresses are automatically generated by the internal column address counter.

The **mode register** is to justify the SDRAM operation and function into desired system conditions. MODE REGISTER TABLE shows how SDRAM can be configured for system requirement by mode register programming.

CLOCK (CLK) and CLOCK ENABLE (CKE)

All input and output signals of SDRAM use register type buffers. A CLK is used as a trigger for the register and internal burst counter increment. All inputs are latched by a positive edge of CLK. All outputs are validated by the CLK. CKE is a high active clock enable signal. When CKE = Low is latched at a clock input during active cycle, the next clock will be internally masked. During idle state (all banks have been precharged), the Power Down mode (standby) is entered with CKE = Low and this will make extremely low standby current.

CHIP SELECT (CS)

 $\overline{\text{CS}}$ enables all commands inputs, $\overline{\text{RAS}}$, $\overline{\text{CAS}}$, and $\overline{\text{WE}}$, and address input. When $\overline{\text{CS}}$ is High, command signals are negated but internal operation such as burst cycle will not be suspended. If such a control isn't needed, $\overline{\text{CS}}$ can be tied to ground level.

COMMAND INPUT (RAS, CAS and WE)

Unlike a conventional DRAM, \overline{RAS} , \overline{CAS} , and \overline{WE} do not directly imply SDRAM operation, such as Row address strobe by \overline{RAS} . Instead, each combination of \overline{RAS} , \overline{CAS} , and \overline{WE} input in conjunction with \overline{CS} input at a rising edge of the CLK determines SDRAM operation. Refer to FUNCTIONAL TRUTH TABLE in page 5.

ADDRESS INPUT (A₀ to A₁₁)

Address input selects an arbitrary location of a total of 2,097,152 words of each memory cell matrix. A total of twenty one address input signals are required to decode such a matrix. SDRAM adopts an address multiplexer in order to reduce the pin count of the address line. At a Bank Active command (ACTV), twelve Row addresses are initially latched and the remainder of nine Column addresses are then latched by a Column address strobe command of either a Read command (READ or READA) or Write command (WRIT or WRITA).

BANK SELECT (A₁₂, A₁₃)

This SDRAM has four banks and each bank is organized as 2 M words by 8-bit. Bank selection by A₁₃, A₁₂ occurs at Bank Active command (ACTV) followed by read (READ or READA), write (WRIT or WRITA), and precharge command (PRE).

DATA INPUT AND OUTPUT (DQ₀ to DQ₇)

Input data is latched and written into the memory at the clock following the write command input. Data output is obtained by the following conditions followed by a read command input:

trac; from the bank active command when tree (min) is satisfied. (This parameter is reference only.)

tcac; from the read command when tRCD is greater than tRCD (min). (This parameter is reference only.)

tac ; from the clock edge after trac and toac.

The polarity of the output data is identical to that of the input. Data is valid between access time (determined by the three conditions above) and the next positive clock edge (toh).

DATA I/O MASK (DQM)

DQM is an active high enable input and has an output disable and input mask function. During burst cycle and when DQM = High is latched by a clock, input is masked at the same clock and output will be masked at the second clock later while internal burst counter will increment by one or will go to the next stage depending on burst type.

BURST MODE OPERATION AND BURST TYPE

The burst mode provides faster memory access. The burst mode is implemented by keeping the same Row address and by automatic strobing column address. Access time and cycle time of Burst mode is specified as tac and tok, respectively. The internal column address counter operation is determined by a mode register which defines burst type and burst count length of 1, 2, 4 or 8 bits of boundary. In order to terminate or to move from the current burst mode to the next stage while the remaining burst count is more than 1, the following combinations will be required:

Current Stage	Next Stage	ı	Method (Assert the following command)
Burst Read	Burst Read		Read Command
Burst Read	Burst Write	1st Step	Mask Command (Normally 3 clock cycles)
Buist Read	buist write	2nd Step	Write Command after lowd
Burst Write	Burst Write		Write Command
Burst Write	Burst Read		Read Command
Burst Read	Precharge		Precharge Command
Burst Write	Precharge		Precharge Command

The burst type can be selected either sequential or interleave mode if burst length is 2, 4 or 8. The sequential mode is an incremental decoding scheme within a boundary address to be determined by count length, it assigns +1 to the previous (or initial) address until reaching the end of boundary address and then wraps round to least significant address (= 0). The interleave mode is a scrambled decoding scheme for A_0 and A_2 . If the first access of column address is even (0), the next address will be odd (1), or vice-versa.

(Continued)

When the full burst operation is executed at single write mode, Auto-precharge command is valid only at write operation.

The burst type can be selected either sequential or interleave mode. But only the sequential mode is usable to the full column burst. The sequential mode is an incremental decoding scheme within a boundary address to be determined by burst length, it assigns +1 to the previous (or initial) address until reaching the end of boundary address and then wraps round to least significant address (= 0).

Burst Length	Starting Column Address A ₂ A ₁ A ₀	Sequential Mode	Interleave
2	X X 0	0 – 1	0 – 1
2	X X 1	1 – 0	1 – 0
	X 0 0	0-1-2-3	0-1-2-3
4	X 0 1	1-2-3-0	1-0-3-2
-	X 1 0	2-3-0-1	2-3-0-1
	X 1 1	3-0-1-2	3-2-1-0
	0 0 0	0-1-2-3-4-5-6-7	0-1-2-3-4-5-6-7
	0 0 1	1-2-3-4-5-6-7-0	1-0-3-2-5-4-7-6
	0 1 0	2-3-4-5-6-7-0-1	2-3-0-1-6-7-4-5
8	0 1 1	3-4-5-6-7-0-1-2	3-2-1-0-7-6-5-4
	1 0 0	4-5-6-7-0-1-2-3	4-5-6-7-0-1-2-3
	1 0 1	5-6-7-0-1-2-3-4	5-4-7-6-1-0-3-2
	1 1 0	6-7-0-1-2-3-4-5	6-7-4-5-2-3-0-1
	1 1 1	7-0-1-2-3-4-5-6	7-6-5-4-3-2-1-0

FULL COLUMN BURST AND BURST STOP COMMAND (BST)

The full column burst is an option of burst length and available only at sequential mode of burst type. This full column burst mode is repeatedly access to the same column. If burst mode reaches end of column address, then it wraps round to first column address (= 0) and continues to count until interrupted by the news read (READ) /write (WRIT), precharge (PRE), or burst stop (BST) command. The selection of Auto-precharge option is illegal during the full column burst operation except write command at BURST READ & SINGLE WRITE mode.

The BST command is applicable to terminate the burst operation. If the BST command is asserted during the burst mode, its operation is terminated immediately and the internal state moves to Bank Active.

When read mode is interrupted by BST command, the output will be in High-Z.

For the detail rule, please refer to TIMING DIAGRAM – 8.

When write mode is interrupted by BST command, the data to be applied at the same time with BST command will be ignored.

BURST READ & SINGLE WRITE

The burst read and single write mode provides single word write operation regardless of its burst length. In this mode, burst read operation does not be affected by this mode.

PRECHARGE AND PRECHARGE OPTION (PRE, PALL)

SDRAM memory core is the same as conventional DRAMs', requiring precharge and refresh operations. Precharge rewrites the bit line and to reset the internal Row address line and is executed by the Precharge command (PRE). With the Precharge command, SDRAM will automatically be in standby state after precharge time (trp).

The precharged bank is selected by combination of AP and A_{12} , A_{13} when Precharge command is asserted. If AP = High, all banks are precharged regardless of A_{12} , A_{13} (PALL). If AP = Low, a bank to be selected by A_{12} , A_{13} is precharged (PRE).

The auto-precharge enters precharge mode at the end of burst mode of read or write without Precharge command assertion.

This auto precharge is entered by AP = High when a read or write command is asserted. Refer to FUNCTIONAL TRUTH TABLE.

AUTO-REFRESH (REF)

Auto-refresh uses the internal refresh address counter. The SDRAM Auto-refresh command (REF) generates Precharge command internally. All banks of SDRAM should be precharged prior to the Auto-refresh command. The Auto-refresh command should also be asserted every 16 µs or a total 4096 refresh commands within a 64 ms period.

SELF-REFRESH ENTRY (SELF)

Self-refresh function provides automatic refresh by an internal timer as well as Auto-refresh and will continue the refresh function until cancelled by SELFX.

The Self-refresh is entered by applying an Auto-refresh command in conjunction with CKE = Low (SELF). Once SDRAM enters the self-refresh mode, all inputs except for CKE will be "don't care" (either logic high or low level state) and outputs will be in a High-Z state. During a self-refresh mode, CKE = Low should be maintained. SELF command should only be issued after last read data has been appeared on DQ.

Note: When the burst refresh method is used, a total of 4096 auto-refresh commands within 4 ms must be asserted prior to the self-refresh mode entry.

SELF-REFRESH EXIT (SELFX)

To exit self-refresh mode, apply minimum toksp after CKE brought high, and then the No Operation command (NOP) or the Deselect command (DESL) should be asserted within one trop period. CKE should be held High within one trop period after toksp. Refer to Timing Diagram-16 for the detail.

It is recommended to assert an Auto-refresh command just after the tRC period to avoid the violation of refresh period.

Note: When the burst refresh method is used, a total of 4096 auto-refresh commands within 4 ms must be asserted after the self-refresh exit.

MODE REGISTER SET (MRS)

The mode register of SDRAM provides a variety of different operations. The register consists of four operation fields; Burst Length, Burst Type, CAS latency, and Operation Code. Refer to MODE REGISTER TABLE.

The mode register can be programmed by the Mode Register Set command (MRS). Each field is set by the address line. Once a mode register is programmed, the contents of the register will be held until re-programmed by another MRS command (or part loses power). MRS command should only be issued on condition that all DQ is in Hi-Z.

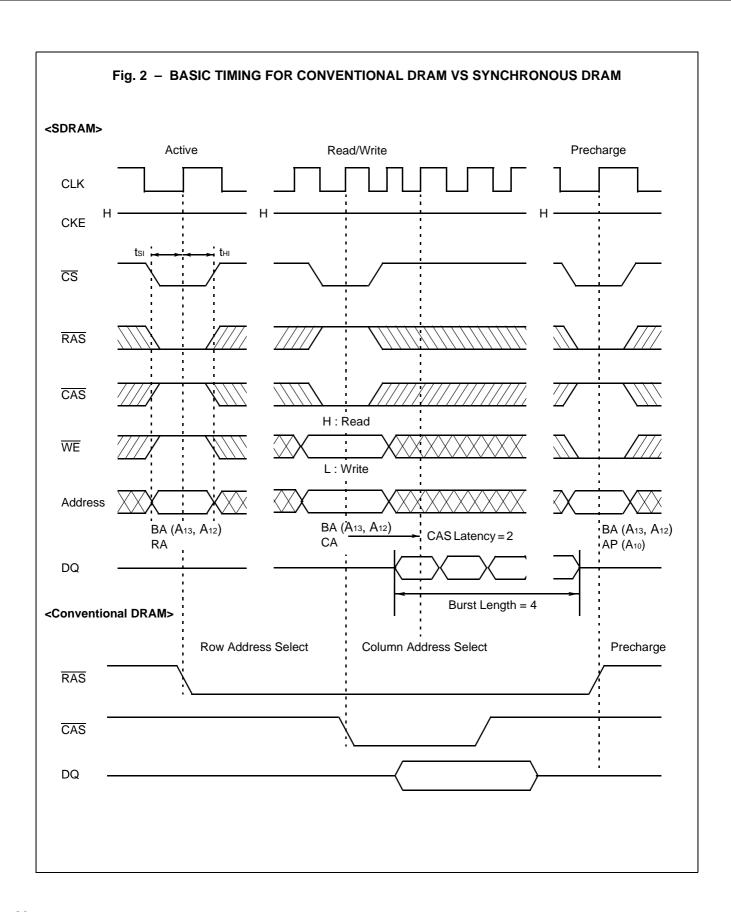
The condition of the mode register is undefined after the power-up stage. It is required to set each field after initialization of SDRAM. Refer to POWER-UP INITIALIZATION below.

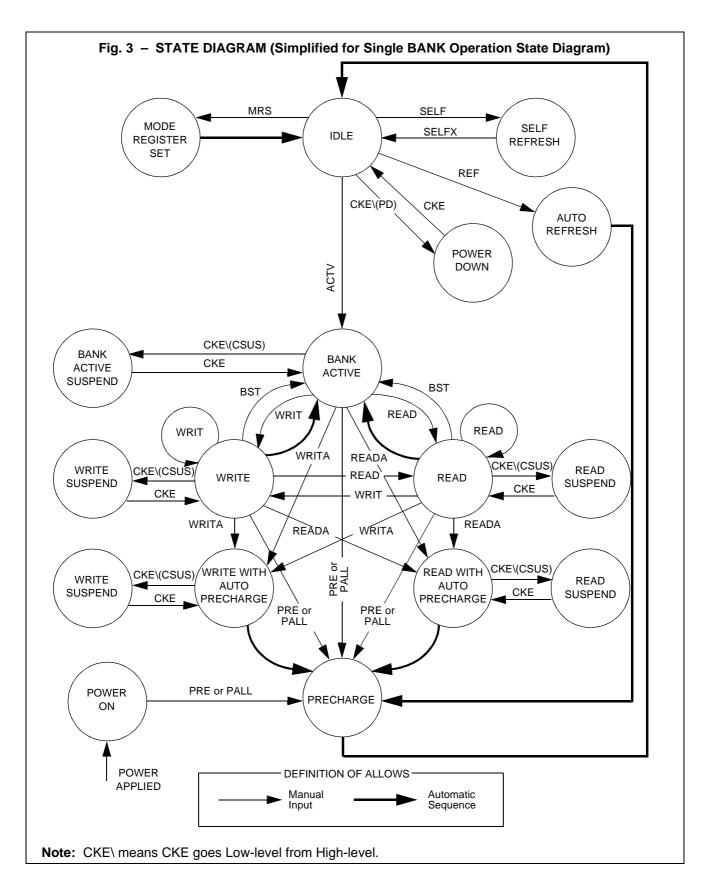
POWER-UP INITIALIZATION

The SDRAM internal condition after power-up will be undefined. It is required to follow the following Power On Sequence to execute read or write operation.

- 1. Apply power and start clock. Attempt to maintain either NOP or DESL command at the input.
- 2. Maintain stable power, stable clock, and NOP condition for a minimum of 100 μ s.
- 3. Precharge all banks by Precharge (PRE) or Precharge All command (PALL).
- 4. Assert minimum of 2 Auto-refresh command (REF).
- 5. Program the mode register by Mode Register Set command (MRS).

In addition, it is recommended DQM and CKE to track Vcc to insure that output is High-Z state. The Mode Register Set command (MRS) can be set before 2 Auto-refresh command (REF).





■ BANK OPERATION COMMAND TABLE

MINIMUM CLOCK LATENCY OR DELAY TIME FOR SINGLE BANK OPERATION

Second command (same bank) First command	MRS	ACTV	READ	READA *	WRIT	WRITA *	PRE	PALL	REF	SELF	BST
MRS	trsc	trsc					trsc	trsc	trsc	trsc	trsc
ACTV			trcd	trcd	trcd	trcd	t ras	tras			1
READ			1	1	*5 1	*5 1	*4 1	1			1
READA	*1 *2 BL+ t _{RP}	BL+ t _{RP}					*4 BL+ t _{RP}	*4 BL+ t _{RP}	BL+	*2 *7 BL+ t _{RP}	
WRIT			t wr	t wr	1	1	*4 t DPL	*4 t dpl			1
WRITA	*2 BL-1 + t _{DAL}	BL-1 + t _{DAL}					*4 BL-1 + t _{DAL}	*4 BL-1 + t _{DAL}	*2 BL-1 + t _{DAL}	*2 BL-1 + t _{DAL}	
PRE	*2 *3 t RP	t RP					1	1	*2 t RP	*2 *6 t RP	1
PALL	*3 t RP	t RP					1	1	t RP	*6 t RP	1
REF	t RC	t RC					t RC	trc	t RC	t RC	t RC
SELFX	t rc	t rc					trc	trc	trc	t rc	trc

Notes: *1. If $t_{RP}(min) \le CL \times t_{CK}$, minimum latency is a sum of $(BL + CL) \times t_{CK}$.

- *2. Assume all banks are in Idle state.
- *3. Assume output is in High-Z state.
- *4. Assume tras(min) is satisfied.
- *5. Assume no I/O conflict.
- *6. Assume after the last data have been appeared on DQ.
- *7. If $t_{RP}(min) \le (CL-1) \times t_{CK}$, minimum latency is a sum of $(BL + CL-1) \times t_{CK}$.

	Illegal Command
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■ MULTI BANK OPERATIVE COMMAND TABLE

MINIMUM CLOCK LATENCY OR DELAY TIME FOR MULTI BANK OPERATION

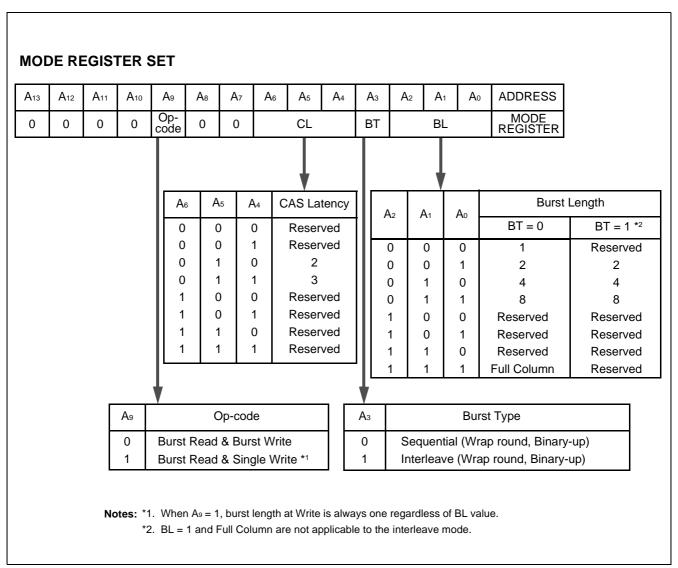
Second command (other bank) First command	MRS	ACTV	READ of	READA 5, 5, 5	WRIT 5.	WRITA 5.4	PRE	PALL	REF	SELF	BST
MRS	trsc	trsc					trsc	trsc	trsc	trsc	trsc
ACTV		*2 t rrd	*7 1	*7 1	*7 1	*7 1	*6 *7 1	*7 tras			1
READ		*2 *4	1	1	*10 1	*10 1	*6 1	*6 1			1
READA	*1 *2 BL+ t _{RP}	*2 *4	*6 1	*6 1	*6 *10	*6 *10 1	*6 1	*6 BL+ t _{RP}	*2 BL+ t _{RP}	*2 *9 BL+ t _{RP}	
WRIT		*2 *4	1	1	1	1	*6 1	*6 t dpl			1
WRITA	*2 BL-1 + t _{DAL}	*2 *4 1	*6 1	*6 1	*6 1	*6 1	*6 1	*6 BL-1 + t _{DAL}	*2 BL-1 + t _{DAL}	*2 BL-1 + t _{DAL}	
PRE	*2 *3 t RP	*2 *4 1	*7 1	*7 1	*7 1	*7 1	*6 *7 1	*7 1	*2 t RP	*2 *8 t RP	1
PALL	*3 t RP	t RP					1	1	t RP	*8 t RP	1
REF	t RC	t RC					t RC	t RC	t RC	t RC	t RC
SELFX	t rc	t RC					t rc	t rc	t RC	t rc	t RC

Notes: *1. If $t_{RP}(min) \le CL \times t_{CK}$, minimum latency is a sum of $(BL + CL) \times t_{CK}$.

- *2. Assume bank of the object is in Idle state.
- *3. Assume output is in High-Z state.
- *4. trrd(min) of other bank (second command will be asserted) is satisfied.
- *5. Assume other bank is in active, read or write state.
- *6. Assume tras(min) is satisfied.
- *7. Assume other banks are not in READA/WRITA state.
- *8. Assume after the last data have been appeared on DQ.
- *9. If $t_{RP}(min) \le (CL-1) \times t_{CK}$, minimum latency is a sum of $(BL + CL-1) \times t_{CK}$.
- *10. Assume no I/O conflict.

	Illegal Command
--	-----------------

■ MODE REGISTER TABLE



■ ABSOLUTE MAXIMUM RATINGS (See WARNING)

Parameter	Symbol	Value	Unit
Voltage of Vcc Supply Relative to Vss	Vcc, Vccq	-0.5 to +4.6	V
Voltage at Any Pin Relative to Vss	VIN, VOUT	-0.5 to +4.6	V
Short Circuit Output Current	Іоит	±50	mA
Power Dissipation	P _D	1.3	W
Storage Temperature	Тѕтс	-55 to +125	°C

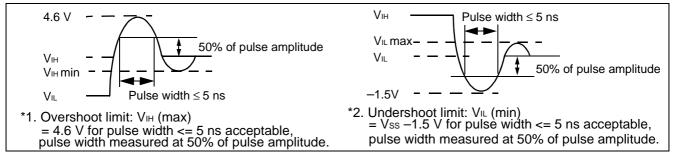
WARNING: Semiconductor devices can be permanently damaged by application of stress (voltage, current, temperature, etc.) in excess of absolute maximum ratings. Do not exceed these ratings.

■ RECOMMENDED OPERATING CONDITIONS

(Referenced to Vss)

Parameter	Notes	Symbol	Min.	Тур.	Max.	Unit
Supply Voltage		Vcc, Vccq	3.0	3.3	3.6	V
Supply Voltage		Vss, Vssq	0	0	0	V
Input High Voltage	*1	VIH	2.0	_	Vcc + 0.5	V
Input Low Voltage	*2	VIL	-0.5	_	0.8	V
Ambient Temperature		TA	0	_	70	°C

Notes:



WARNING: The recommended operating conditions are required in order to ensure the normal operation of the semiconductor device. All of the device's electrical characteristics are warranted when the device is operated within these ranges.

Always use semiconductor devices within their recommended operating condition ranges. Operation outside these ranges may adversely affect reliability and could result in device failure.

No warranty is made with respect to uses, operating conditions, or combinations not represented on the data sheet. Users considering application outside the listed conditions are advised to contact their FUJITSU representatives beforehand.

■ CAPACITANCE

 $(T_A = 25^{\circ}C, f = 1 \text{ MHz})$

Parameter	Symbol	Min.	Тур.	Max.	Unit
Input Capacitance, Except for CLK	C _{IN1}	2.5	_	5.0	pF
Input Capacitance for CLK	C _{IN2}	2.5	_	4.0	pF
I/O Capacitance	C _{I/O}	4.0	_	6.5	pF

■ DC CHARACTERISTICS

(At recommended operating conditions unless otherwise noted.) Note *1, *2 , *3 $\,$

Do-	motor	Cumbal	Condition	Va	Value Min. Max.	
Para	ameter	Symbol	Condition	Min. Max. 2.4 —		Unit
Output High Voltage)	V _{OH(DC)}	Iон = −2 mA	2.4	_	V
Output Low Voltage		V _{OL(DC)}	IoL = 2 mA	_	0.4	V
Input Leakage Curre	ent (Any Input)	lu	$0 \text{ V} \le V_{\text{IN}} \le V_{\text{CC}};$ All other pins not under test = 0 V	- 5	5	μА
Output Leakage Cui	rrent	ILO	0 V ≤ V _{IN} ≤ V _{CC} ; Data out disabled	-5	5	μΑ
	MB81F64842D-75		Burst Length = 1 trc = min		85	
Operating Current (Average Power	MB81F64842D-102 /-102L	Icc1s	tcκ = min One bank active Output pin open	_	80	mA
Supply Current)	Reference Value @66MHz(CL=2)		Addresses changed up to one time during tck (min) $0 \text{ V} \leq \text{V}_{\text{IN}} \leq \text{V}_{\text{IL}} \text{ max}$ $\text{V}_{\text{IH}} \text{ min} \leq \text{V}_{\text{IN}} \leq \text{V}_{\text{CC}}$		5 5 85	
		Ісс2Р	CKE = V_{IL} All banks idle $t_{CK} = min$ Power down mode $0 \ V \le V_{IN} \le V_{IL} \ max$ $V_{IH} \ min \le V_{IN} \le V_{CC}$	_	1.0	mA
	MB81F64842D-75 /-102	lassas	CKE = V _{IL} All banks idle CLK = V _{IH} or V _{IL}		1.0	mA
Precharge Standby	MB81F64842D-102L	ICC2PS	Power down mode $0 \text{ V} \leq \text{V}_{\text{IN}} \leq \text{V}_{\text{IL}} \text{ max}$ $\text{V}_{\text{IH}} \text{ min} \leq \text{V}_{\text{IN}} \leq \text{V}_{\text{CC}}$	_	80 65 1.0 1.0 0.5 15	IIIA
Current (Power Supply Current)	MB81F64842D-75		CKE = Vℍ All banks idle, tcκ = 15 ns NOP command only,		15	
ounding.	MB81F64842D-102 /-102L	Icc2N	Input signals (except to CMD) are changed one	_	15	mA
	Reference Value @66MHz(CL=2)		time during 30 ns $0 \text{ V} \le \text{V}_{\text{IN}} \le \text{V}_{\text{IL}} \text{ max}$ $\text{V}_{\text{IH}} \text{ min} \le \text{V}_{\text{IN}} \le \text{V}_{\text{CC}}$		15	
		Icc2NS	CKE = VIH All banks idle CLK =VIH or VIL Input signal are stable 0 V ≤ VIN ≤ VIL max VIH min ≤ VIN ≤ VCC	_	2	mA

(Continued)

Dara	Parameter		Condition	Va	Unit	
Fala	imeter	Symbol	Condition	Min.	Max.	Unit
	MB81F64842D-75 /-102		CKE = V _I L Any bank active		2 1 1 25 25 25 25 25 100 70 150 140 100 1	
	MB81F64842D-102L	Іссзр		I		mA
		Іссзрѕ	$CKE = V_{IL}$ $Any bank active$ $CLK = V_{IH} or V_{IL}$ $0 \ V \le V_{IN} \le V_{IL} max$ $V_{IH} min \le V_{IN} \le V_{CC}$	l	1	mA
Active Standby Current	MB81F64842D-75		CKE = V _{IH} Any bank active		1 25 25 25 25 25 135 100 70 150 140	
(Power Supply Current)	MB81F64842D-102 /-102L	Іссзи	tcκ = 15 ns NOP command only, Input signals (except to	_		mA
	Reference Value @66MHz(CL=2)		CMD) are changed one time during 30 ns $0 \text{ V} \le \text{V}_{\text{IN}} \le \text{V}_{\text{IL}}$ max V_{IH} min $\le \text{V}_{\text{IN}} \le \text{V}_{\text{CC}}$			
		Іссзиѕ	CKE = VIH Any bank active CLK = VIH or VIL Input signals are stable $0 \text{ V} \leq \text{VIN} \leq \text{VIL} \text{ max}$ VIH min $\leq \text{VIN} \leq \text{VCC}$	_		mA
	MB81F64842D-75		tcκ = min Burst Length = 4		135	
Burst mode Current (Average Power	MB81F64842D-102 /-102L	Icc4	Output pin open All-banks active	_	100	mA
Supply Current)	Reference Value @66MHz(CL=2)		Gapless data $0 \text{ V} \leq \text{V}_{\text{IN}} \leq \text{V}_{\text{IL}} \text{ max}$ $\text{V}_{\text{IH}} \text{ min} \leq \text{V}_{\text{IN}} \leq \text{V}_{\text{CC}}$		70	
	MB81F64842D-75		Auto-refresh;		150	
Refresh Current #1 (Average Power	MB81F64842D-102 /-102L	Icc5	tck = min trc = min	_	25 25 25 27 28 28 29 29 20 20 20 20 20 20 20 20 20 20 20 20 20	mA
Supply Current)	Reference Value @66MHz(CL=2)		$ 0 \ V \le V_{IN} \le V_{IL} \ max $			
Refresh Current #2	MB81F64842D-75 Current #2 /-102		Self-refresh; tck = min		1	mA
(Average Power Supply Current)	MB81F64842D-102L	Icc ₆		_	500	μA

Notes: *1. All voltage are referenced to Vss.

^{*2.} DC characteristics are measured after following the POWER-UP INITIALIZATION procedure.

^{*3.} lcc depends on the output termination or load conditions, clock cycle rate, signal clocking rate. The specified values are obtained with the output open and no termination register.

^{*4.} This value is for reference only.

■ AC CHARACTERISTICS

(At recommended operating conditions unless otherwise noted.) Note *1, *2, *3

								· · ·		
Parameter	Notes		Symbol	MB81F64842D -75		MB81F64842D -102/-102L		Reference Value @66MHz(CL=2)		Unit
				Min.	Max.	Min.	Max.	Min.	Max.	
Clock Period		CL = 2	t ck2	10 7.5	_	10		15		ns ns
		CL = 3	t cкз			10	_	10		
Clock High Time	*5		t cH	2.5	_	3	_	3	_	ns
Clock Low Time	*5		t cL	2.5		3	_	3	_	ns
Input Setup Time	*5		t sı	1.5	_	2	_	2	_	ns
Input Hold Time	*5		tнı	0.8	_	1	_	1	_	ns
Access Time from Clock (tck = min)	*5,6,7	CL = 2	t _{AC2}	_	6	_	6		8	ns
		CL = 3	t _{AC3}		5.4		6	_	6	ns
Output in Low-Z	*5		t LZ	0	_	0	_	0	_	ns
Output in High-Z	*5,8	CL = 2	t HZ2	3	6	3	6	3	8	ns
		CL = 3	t HZ3	2.7	5.4		6		6	ns
Output Hold Time	*5,7	CL = 2	t он	3	_	3	_	3	_	ns
		CL = 3		2.7						ns
Time between Auto-Refresh command interval *4			t REFI	_	15.6	_	15.6	_	15.6	μs
Time between Refresh			t REF	_	64	_	64	_	64	ms
Transition Time			t⊤	0.5	10	0.5	10	0.5	10	ns
CKE Setup Time for Power Down *5 Exit Time		t cksp	1.5	_	2	_	2	_	ns	

BASE VALUES FOR CLOCK COUNT/LATENCY

Parameter Note	Notes	Symbol	MB81F64842D -75			MB81F64842D -102/-102L		Reference Value @66MHz(CL=2)		Unit
Turdinotor Notes	•		Min.		Max.	Min.	Max.	Min.	Max.	
			CL=3	CL=2	IVIAX.	WIII.	Wax.	IVIIII.	IVIAX.	
RAS Cycle Time *9		t _{RC}	67.5	70	_	70	_	80	_	ns
RAS Precharge Time	t RP	22.5	20	_	20	_	30	_	ns	
RAS Active Time	tras	45	50	110000	50	110000	50	110000	ns	
RAS to CAS Delay Time	t RCD	22.5	20	_	20	_	30	_	ns	
Write Recovery Time	twr	7.5	10	_	10	_	10	_	ns	
RAS to RAS Bank Active Delay Time		t rrd	15	20	_	20	_	20	_	ns
Data-in to Precharge Lead Time		t DPL	15	10	_	10	_	10	_	ns
Data-in to Active/ Refresh Command	CL=2	t DAL2	_	1 cyc + t _{RP}	_	1 cyc + t _{RP}	_	1 cyc + t _{RP}	_	ns
Period	CL=3	t DAL3	2 cyc + t _{RP}	_	_	2 cyc + t _{RP}	_	2 cyc + t _{RP}	_	ns
Mode Resister Set Cycle Time		trsc	15	20	_	20	_	20	_	ns

CLOCK COUNT FORMULA Note *10

 $\begin{array}{c|c} \textbf{Clock} \geq & \underline{ & \textbf{Base Value} \\ \hline \textbf{Clock Period} & \textbf{(Round off a whole number)} \end{array}$

LATENCY - FIXED VALUES

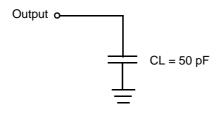
(The latency values on these parameters are fixed regardless of clock period.)

Parameter Notes		Symbol	MB81F64842D -75	MB81F64842D -102/-102L	Reference Value @ 66MHz(CL=2)	Unit
CKE to Clock Disable	Іске	1	1	1	cycle	
DQM to Output in High-Z	lpqz	2	2	2	cycle	
DQM to Input Data Delay	IDQD	0	0	0	cycle	
Last Output to Write Comm Delay	lowd	2	2	2	cycle	
Write Command to Input Data Delay		lowd	0	0	0	cycle
Precharge to Output	CL = 2	IROH2	2	2	2	cycle
in High-Z Delay	CL = 3	Іпонз	3	3	3	cycle
Burst Stop Command to	CL = 2	I _{BSH2}	2	2	2	cycle
Output in High-Z Delay	CL = 3	Івѕнз	3	3	3	cycle
CAS to CAS Delay (min)		Iccd	1 1		1	cycle
CAS Bank Delay (min)	ICBD	1	1	1	cycle	

Notes: *1. AC characteristics are measured after following the POWER-UP INITIALIZATION procedure.

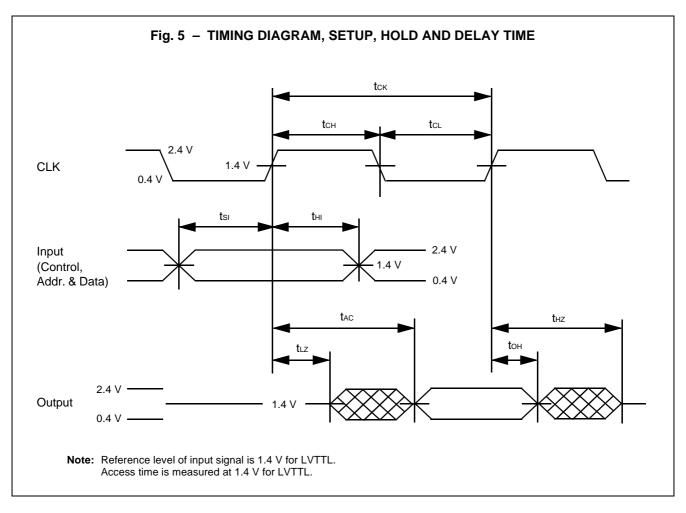
- *2. AC characteristics assume $t_T = 1$ ns and 50 pF of capacitive load.
- *3. 1.4 V is the reference level for measuring timing of input signals. Transition times are measured between V_{IH} (min) and V_{IL} (max). (See Fig. 5)
- *4. This value is for reference only.
- *5. If input signal transition time (tr) is longer than 1 ns; [(tr/2) -0.5] ns should be added to tac (max), thz (max), and toksp (min) spec values, [(tr/2) -0.5] ns should be subtracted from thz (min), thz (min), and toh (min) spec values, and (tr -1.0) ns should be added to toh (min), toh (min), tsi (min), and thi (min) spec values.
- *6. tac also specifies the access time at burst mode .
- *7. tac and toh are the specs value under AC test load circuit shown in Fig. 4.
- *8. Specified where output buffer is no longer driven.
- *9. Actual clock count of trc (Irc) will be sum of clock count of tras (Iras) and trp (Irp).
- *10. All base values are measured from the clock edge at the command input to the clock edge for the next command input. All clock counts are calculated by a simple formula: clock count equals base value divided by clock period (round off to a whole number).

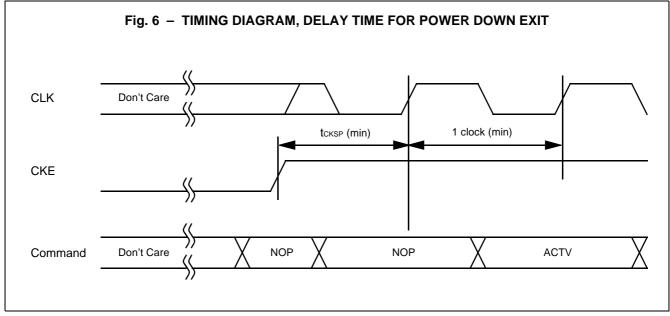
Fig. 4 - OUTPUT LOAD CIRCUIT

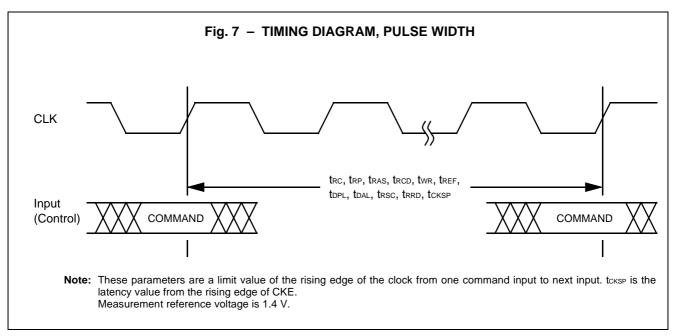


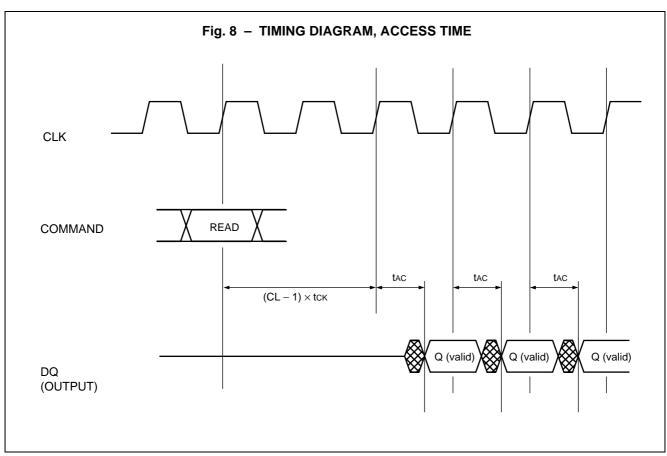
LVTTL

Note: By adding appropriate correlation factors to the test conditions, tac and toh measured when the output is coupled to the Output Load Circuit are within specifications.

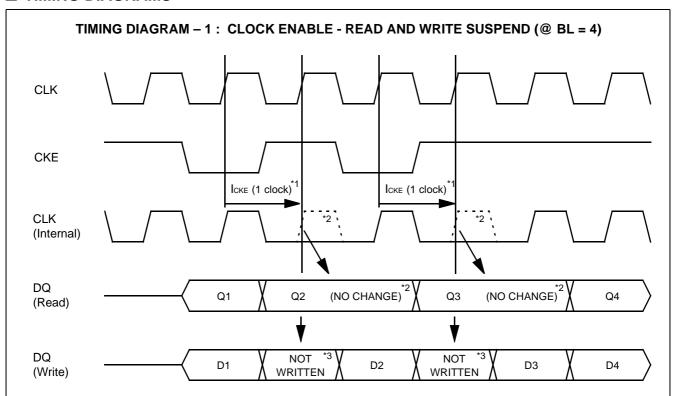








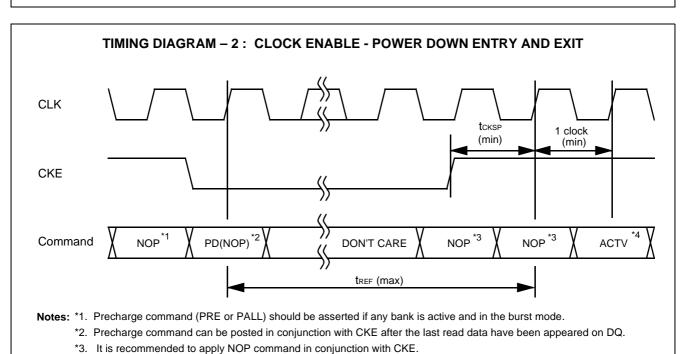
■ TIMING DIAGRAMS

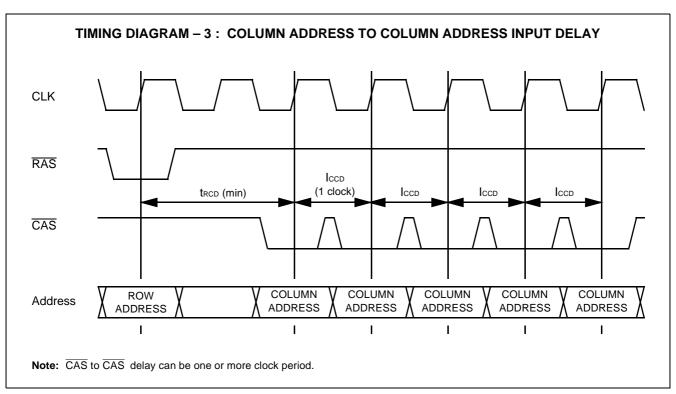


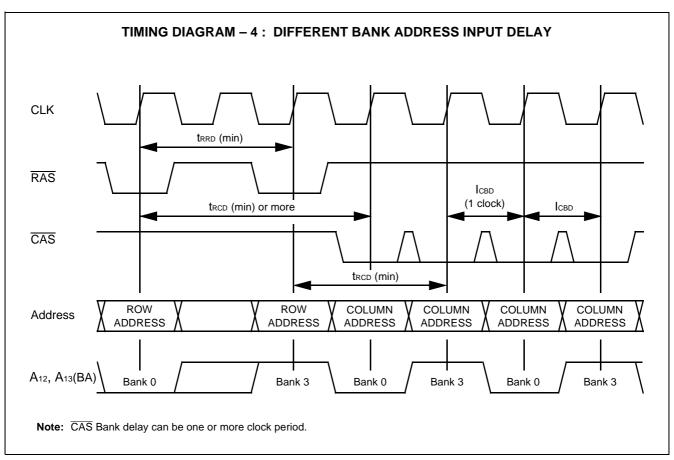
Notes: *1. The latency of CKE (ICKE) is one clock.

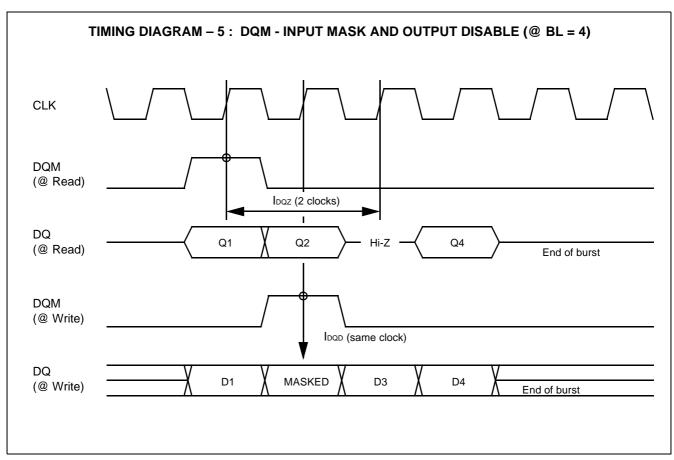
- *2. During read mode, burst counter will not be incremented/decremented at the next clock of CSUS command. Output data remain the same data.
- *3. During the write mode, data at the next clock of CSUS command is ignored.

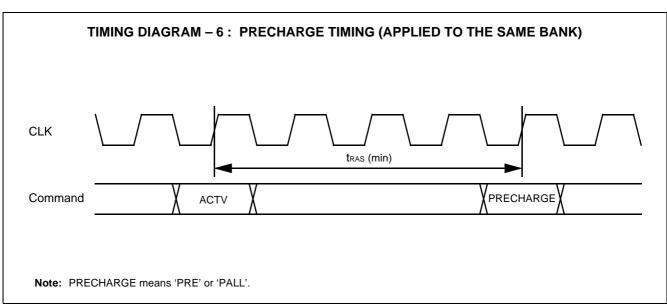
*4. The ACTV command can be latched after tcksp (min) + 1 clock (min).

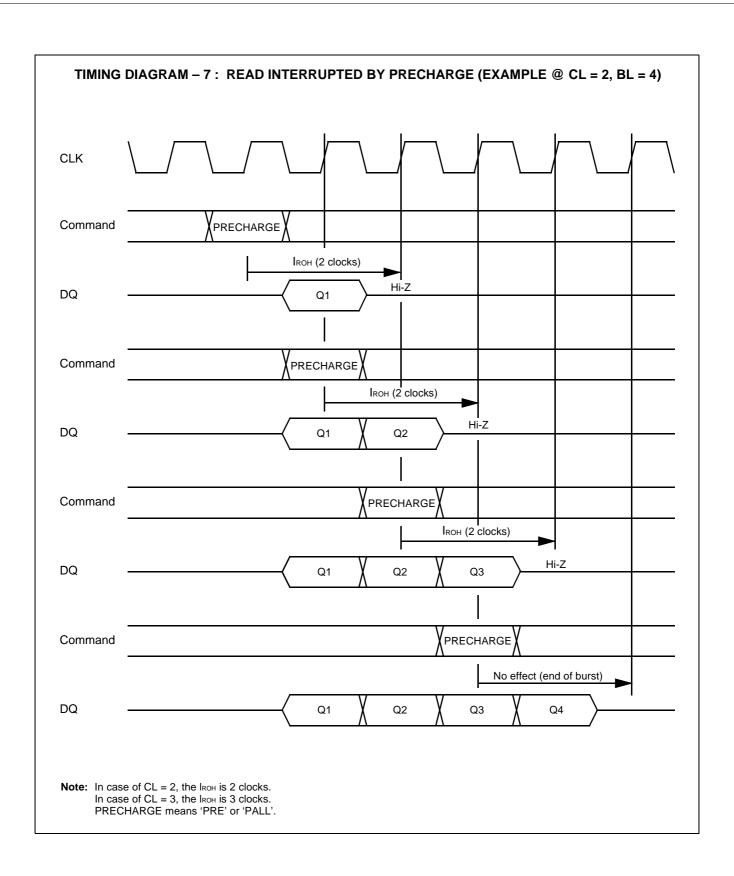


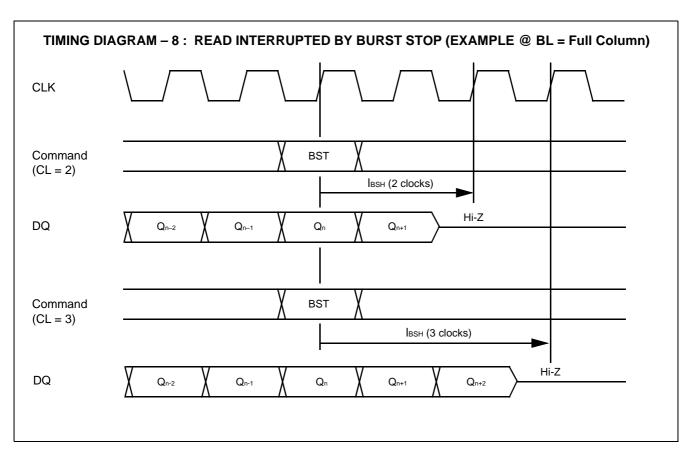


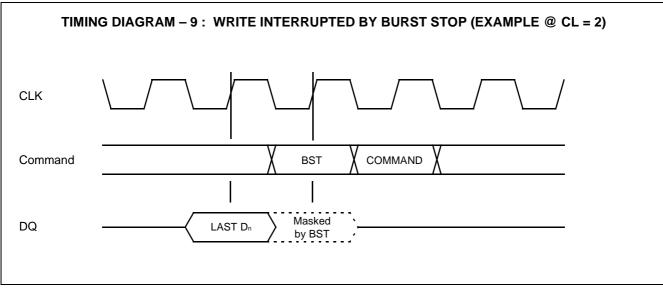


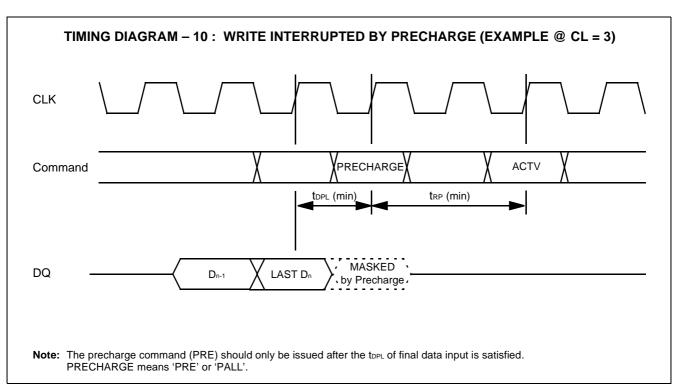


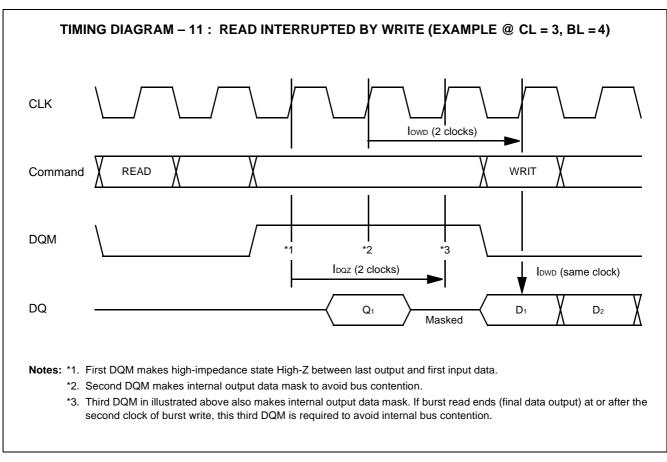


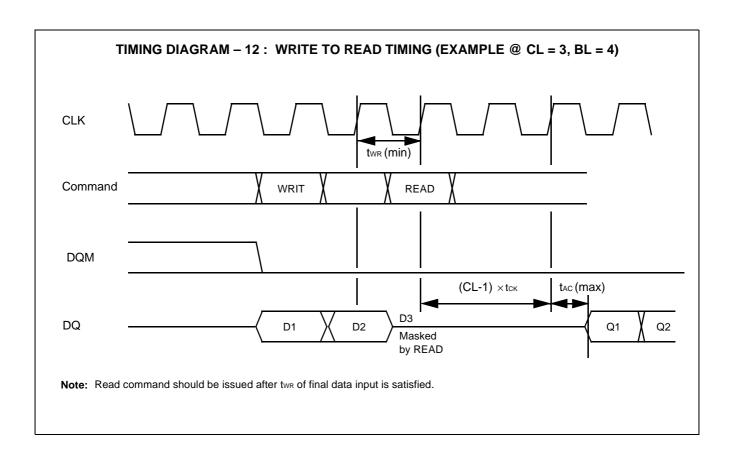


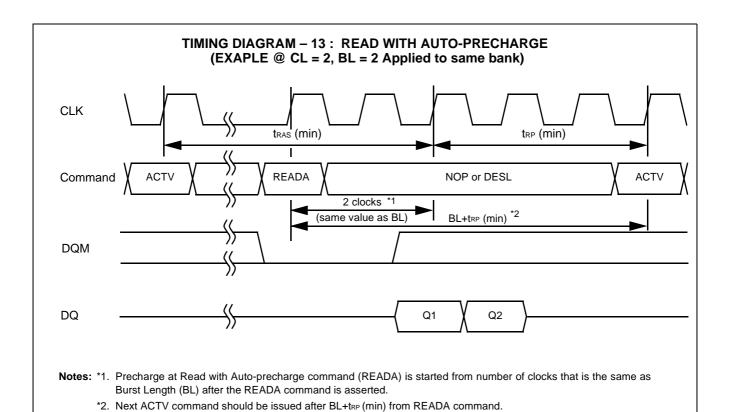


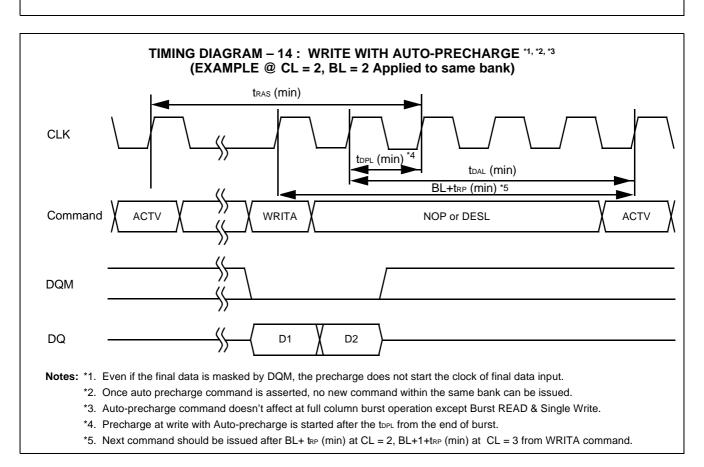


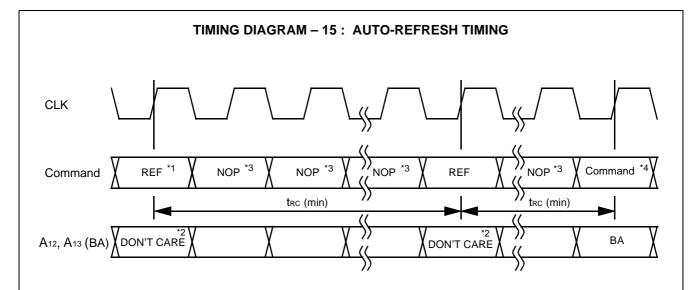






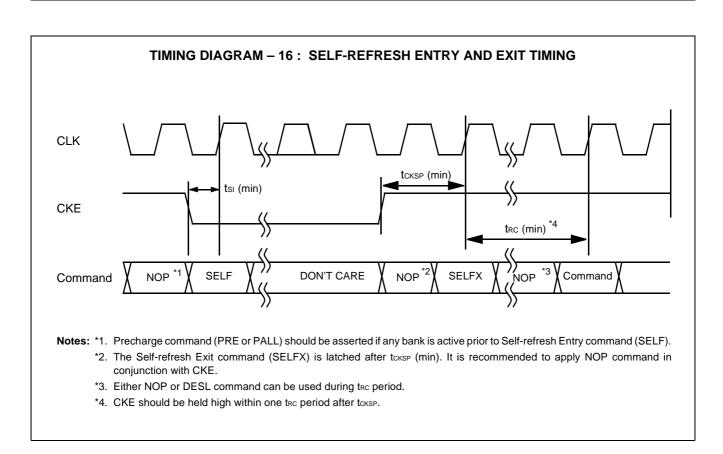


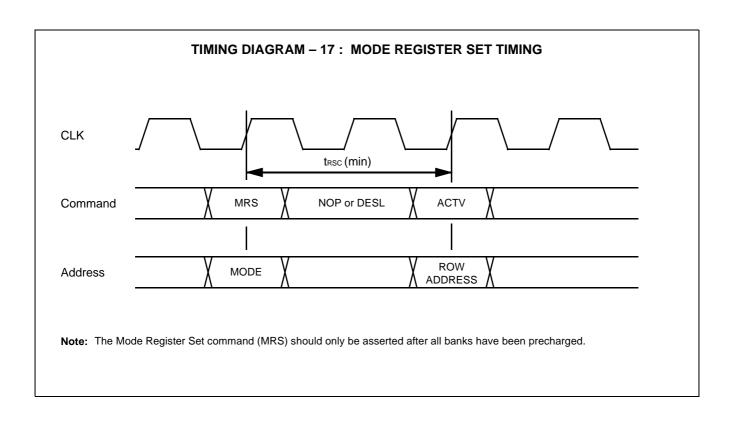




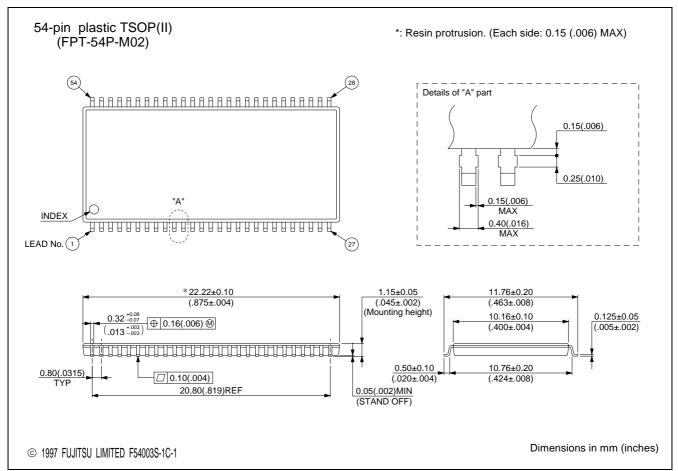
Notes: *1. All banks should be precharged prior to the first Auto-refresh command (REF).

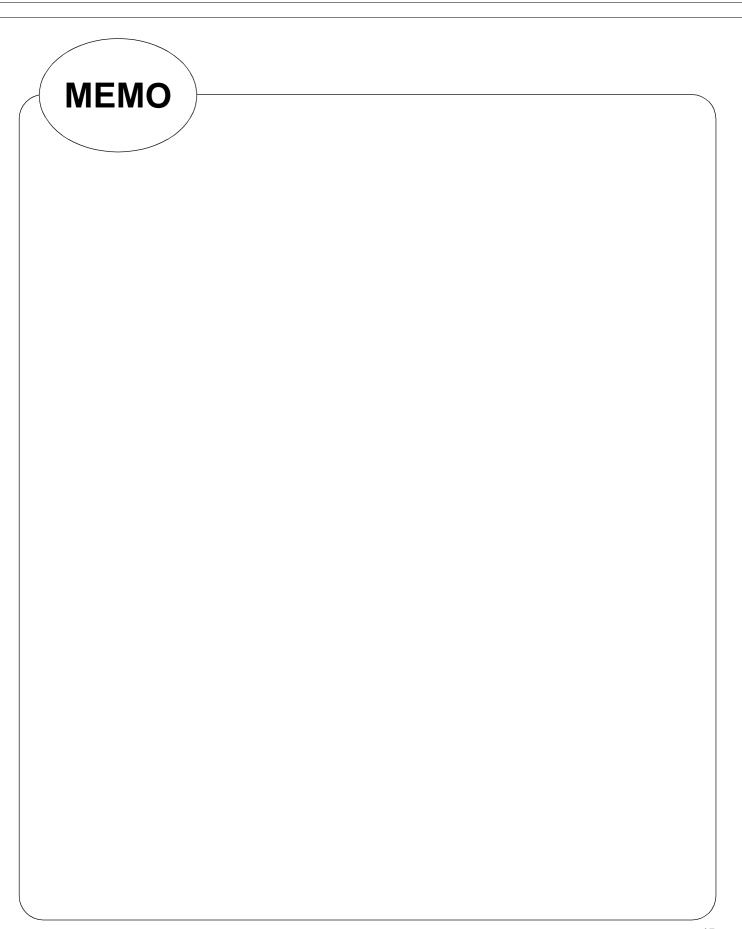
- *2. Bank select is ignored at REF command. The refresh address and bank select are selected by internal refresh counter.
- *3. Either NOP or DESL command should be asserted during tac period while Auto-refresh mode.
- *4. Any activation command such as ACTV or MRS command other than REF command should be asserted after tec from the last REF command.

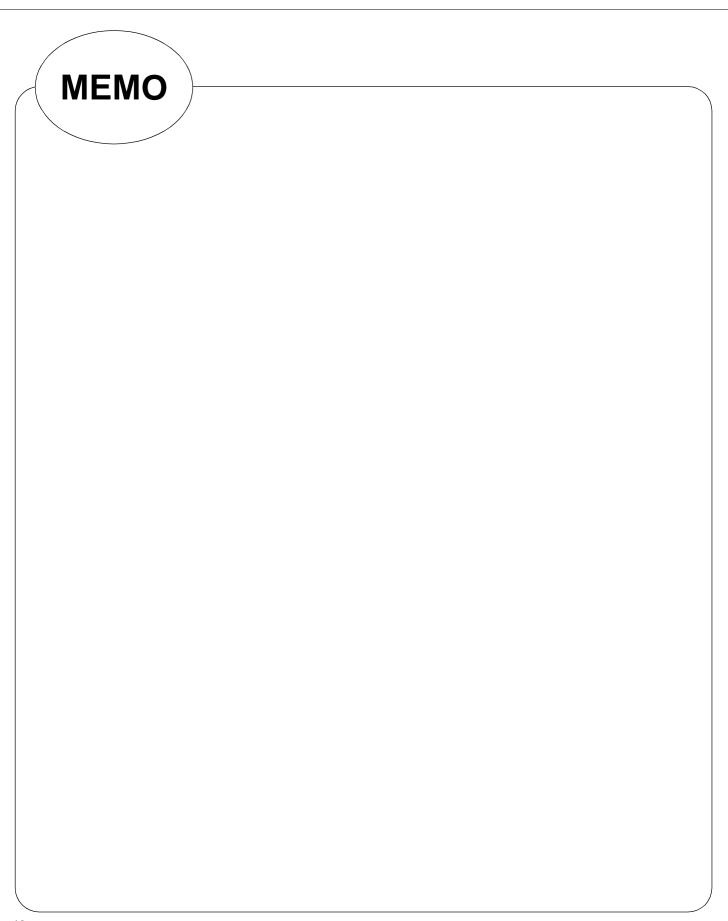


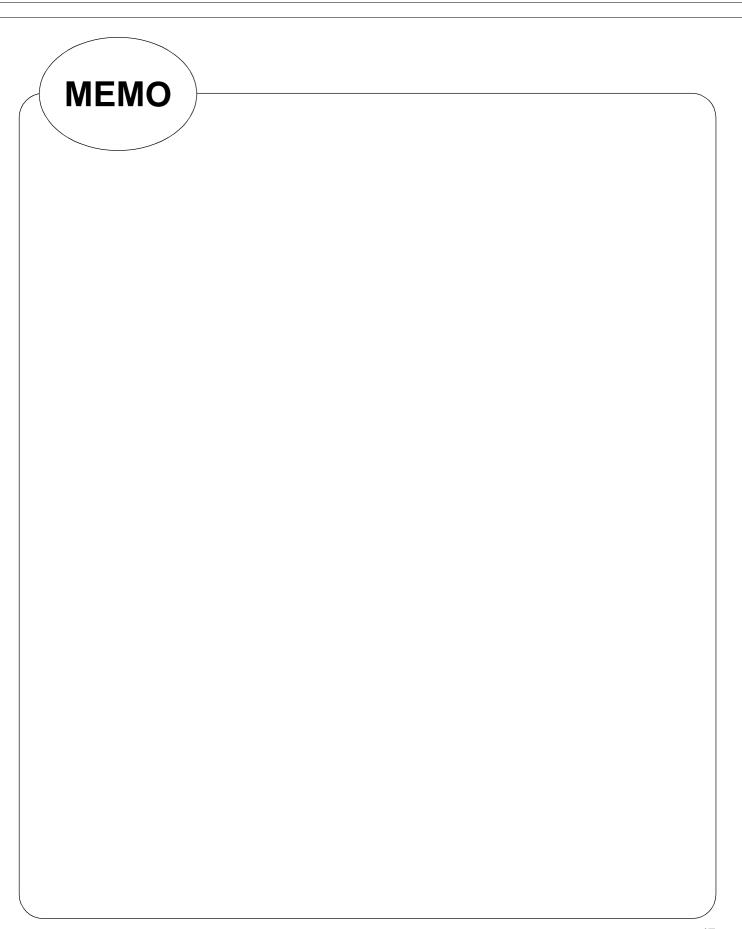


■ PACKAGE DIMENSION









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